

Search Notes

Application/Control No.

10/666,317

Examiner

Eric B. Chen

Applicant(s)/Patent under
Reexamination

MUI ET AL.

Art Unit

1765

SEARCHED

Class	Subclass	Date	Examiner
-			

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor search (UPDATED)	10/19/2005	EC
EAST (all databases) (UPDATED) - see search history printout	10/19/2005	EC
438/5,9,14,16,714,719-721,723,724, 740,743,744; 430/5; 216/60,67,79 (text search only) (UPDATED)	10/19/2005	EC